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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/710,235	06/28/2004	Chun-Liang Tai	LKSP0035USA	4234
27765	7590	01/02/2008		
NORTH AMERICA INTELLECTUAL PROPERTY CORPORATION			EXAMINER	
P.O. BOX 506			GAKH, YELENA G	
MERRIFIELD, VA 22116			ART UNIT	PAPER NUMBER
			1797	
			NOTIFICATION DATE	DELIVERY MODE
			01/02/2008	ELECTRONIC

**Please find below and/or attached an Office communication concerning this application or proceeding.**

The time period for reply, if any, is set in the attached communication.

Notice of the Office communication was sent electronically on above-indicated "Notification Date" to the following e-mail address(es):

winstonhsu.uspto@gmail.com  
Patent.admin.uspto.Rcv@naipo.com  
mis.ap.uspto@naipo.com.tw

## Office Action Summary

**Application No.**

10/710,235

**Applicant(s)**

TAI ET AL.

**Examiner**

Yelena G. Gakh, Ph.D.

**Art Unit**

1797

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

### Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

### Status

- 1) ☒ Responsive to communication(s) filed on 24 June 2007.
- 2a) ☐ This action is **FINAL**.                      2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

### Disposition of Claims

- 4) ☒ Claim(s) 1-11 is/are pending in the application.
- 4a) Of the above claim(s) \_\_\_\_\_ is/are withdrawn from consideration.
- 5) ☐ Claim(s) \_\_\_\_\_ is/are allowed.
- 6) ☒ Claim(s) 1-11 is/are rejected.
- 7) ☐ Claim(s) \_\_\_\_\_ is/are objected to.
- 8) ☐ Claim(s) \_\_\_\_\_ are subject to restriction and/or election requirement.

### Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☐ The drawing(s) filed on \_\_\_\_\_ is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.  
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).  
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

### Priority under 35 U.S.C. § 119

- 12) ☒ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All    b) ☐ Some \* c) ☒ None of:
1. ☒ Certified copies of the priority documents have been received.
  2. ☐ Certified copies of the priority documents have been received in Application No. \_\_\_\_\_.
  3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

\* See the attached detailed Office action for a list of the certified copies not received.

### Attachment(s)

- |  |   |
|--|---|
| 1) <input checked="" type="checkbox"/> Notice of References Cited (PTO-892)                                | 4) <input type="checkbox"/> Interview Summary (PTO-413)<br>Paper No(s)/Mail Date. _____ |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948)                       | 5) <input type="checkbox"/> Notice of Informal Patent Application                       |
| 3) <input type="checkbox"/> Information Disclosure Statement(s) (PTO/SB/08)<br>Paper No(s)/Mail Date _____ | 6) <input type="checkbox"/> Other: _____  |

## DETAILED ACTION

### *Claim Rejections - 35 USC § 112*

1. The following is a quotation of the first paragraph of 35 U.S.C. 112:

The specification shall contain a written description of the invention, and of the manner and process of making and using it, in such full, clear, concise, and exact terms as to enable any person skilled in the art to which it pertains, or with which it is most nearly connected, to make and use the same and shall set forth the best mode contemplated by the inventor of carrying out his invention.

2. Claims 1-11 are rejected under 35 U.S.C. 112, first paragraph, as failing to comply with the written description requirement. The claim(s) contains subject matter which was not described in the specification in such a way as to reasonably convey to one skilled in the relevant art that the inventor(s), at the time the application was filed, had possession of the claimed invention. The specification does not provide any detailed explanation for the processes occurring in the system, which is necessary for performing the method, and is accompanied with black and white artifacts, which are non-descriptive. If the Applicants observed changes in color of tungsten metal film under conditions disclosed in the specification, such changes could be caused by totally different factors, than those disclosed in the specification; the claimed method contradicts the well known prior art on using tungsten as oxygen sensor and on its physical-chemical properties, including color changes in the system upon reaction with oxygen. In other words, what is observed as color changes may be totally unrelated to oxygen leakage, which makes the invention un-enabled. The prior art discloses the following:

Shigeishi teaches "a field ion investigation of oxygen on tungsten":

"the oxygen-tungsten system has been extensively studied for many years and recently, much new information as been obtained in surface structure, work function changes, surface diffusion, adsorption states, and kinetics of oxide formation by a variety of techniques including Leed, electron desorption spectrometry, flash desorption, and field emission microscopy. Recent reviews by McCarroll (1) and Musket (2) summarize these findings and hence need not be repeated here. There are, however, comparatively few reports of the systematic investigation of the tungsten-oxygen system at elevated temperatures by means of field ion spectroscopy (3). It is now generally recognized that oxygen atoms on tungsten cannot be imaged since they are either field desorbed from the surface before imaging voltages are reached or else are buried within the surface (4). Nevertheless, it is also known that when oxygen is chemisorbed, tungsten-tungsten bonds are weakened with the result that in field desorption, both oxygen and an adjacent tungsten atom are stripped off together in the form of tungsten oxide molecular ions. Müller and co-worker's initial atom probe studies (5) have shown that these ions are  $\text{WO}^{3+}$ ,  $\text{WO}_2^{3+}$ ,  $\text{WO}_3^{3+}$ .

Thus the combination of chemisorption and field desorption results in an "etched" surface and from a comparison of the images of clean and etched surfaces the position of the oxygen can be inferred. Filed ion microscopy should therefore be valuable in studying among other things, surface diffusion, preferential adsorption, and penetration of adsorbate into the substrate" (page 997, left and right column).

Bloomer et al. disclose

"a simple detector for small leaks using a thoriated tungsten emitter with oxygen as probe gas" and emphasize that "thoriated tungsten filaments are very sensitive to such gases [as oxygen] and can be used in a leak detection method, applicable to well-baked high vacuum systems, in which oxygen is used as a probe or jacket gas, replacing air entering through any remaining leaks. .... The condition, or sensitivity, of the leak detector is conveniently defined by the fractional change  $I_e/I_e$  in the emission current  $I_e$  from the filament" (page 306, right paragraph).

JP 11339935 A discloses a "ceramic heater for oxygen concentration sensor [that] includes heat resistor which consists of rhenium and tungsten in specific proportions" (DERWENT Title) and is based on detecting changes in electrical resistance. None of the cited references teach color changing of tungsten upon its interaction with oxygen.

The examiner found a reference that does disclose two colors related to tungsten, Bussjager et al. "A spinning disk test stand for two-color, tungsten oxide based optical memory system". However, the colors are related to two forms of tungsten oxides:  $WO_3$  and  $W_2O_5$ . Bussjager indicates:

"the electrochromic and photochromic properties of the tungsten oxide system has been well known [19] for over 30 years.  $WO_3$  is a yellow ["gold"] material that is slightly semiconducting and represents the lowest energy form of tungsten in contact with molecular gas phase oxygen. It exists as a monoclinical solid [20] from room temperatures to approximately 300°-400° C. A first order phase transition to an orthorhombic form occurs in this temperature range, and very little evaporation of tungsten in any form occurs below 300°-400° C. Exchange of oxygen both within the lattice and between the solid and surrounding gas phase is well known [21]. The surface region of the material can be manipulated so that it is either more or less oxygen deficient with respect to stoichiometric  $WO_3$ . **Oxygen deficiency leads to  $W^{+5}$  centers and the changing of the color of the material from yellow to blue.** Concurrent with the color change, electrical properties, e.g. electrical resistance, change by orders of magnitude [22], [23]. The change in the color from yellow to blue in the  $WO_3$  and  $W_2O_5$  system, respectively, is indicative of a change in index of refraction. This change can be purely photochromic or electrochromic" (pages 330-331, Chapter 2. The  $WO_3$  and  $W_2O_5$  system"). According to both mechanisms tungsten oxide loses oxygen.

Furthermore, according to Wikipedia, "pure tungsten is steel-gray to tin-white and is a hard metal".

Therefore, the claimed method contradicts disclosure of the prior art and the known properties of the claimed compounds; at least the examiner failed to find any reference which indicates that tungsten metal is of a golden color. Moreover, changing the color from yellow ("gold") to blue is related to tungsten oxides, rather than tungsten metal, and is caused by loss of oxygen, rather than its gain.

The Applicants are requested to provide more detailed experimental results along with evidence that they observe changes of tungsten film from gold to blue or green, as disclosed in the specification, which occurs upon exposing tungsten to oxygen. The prior art teaches the opposite - that first tungsten is oxidized by oxygen thus providing yellow ("gold") tungsten trioxide  $WO_3$ , while the loss of oxygen from this oxide causes the change of color to blue for the form  $W_2O_5$ . Any references that teach properties of tungsten metal and its ability to change color upon exposing to oxygen according to the instant disclosure, as well as color photographs of the real experiments, will be very much appreciated.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Yelena G. Gakh, Ph.D. whose telephone number is (571) 272-1257. The examiner can normally be reached on 9:30 am - 6:00 pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Jill A. Warden can be reached on (571) 272-1267. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

12/17/2007



**YELENA GAKH  
PRIMARY EXAMINER**